## ENGINEERING REPORT

REPORT SERIAL NO. 1720 DATE

PAGE OF 2-4-75

Electrical Components Division

The Bendix Corporation

Sidney, New York

8

NAME OF EQUIPMENT

INTERFACIAL INSERT FOR ELECTRICAL CONNECTORS

TYPE & PART NO.

SERIAL NO.

CUSTOMER'S NAME & ADDRESS

Lyndon B. Johnson Space Center, NASA R & T Procurement Branch Houston, Texas 77058

NASA CR-

CUSTOMER'S PART NO.

TERMINATION REPORT FOR PROJECT 70886

NAS 9-13899

PURPOSE

Provide connector assemblies and perform design evaluation as required by NASA Contract NAS9-13899 and Bendix Technical Proposal 1003.

SUBJECT

(NASA-CR-141728) INTERFACIAL INSERT FOR ELECTRICAL CONNECTORS Engineering Report (Bendix Corp.) 22 p HC \$3.25 CSCL 09A

- 1. Connector Assemblies
- 1.1 25 interfacial insert assembly kits (L-25274-603) have been shipped per contract requirements. Each assembly consists of one interfacial insert with an interfacial seal on one side, pin contacts molded in place, two mating socket insert assemblies and 42 socket contacts for assembly into socket inserts.

The interfacial insert and ancillary components were designed to be assembled into modified MIL-C-26482 series II connectors to be provided on a possible follow up contract. N75-19537

- 2. Design Evaluation
- 2.1 Conclusions

Unclas G3/33 14452

- The samples and testing performed on this program indicated 2.1.1 that the interfacial insert L-25274-604 can be assembled into specially modified MIL-C-26482 series II connectors.
- 2.1.2 The interfacial insert concept can be utilized in many other standard series connectors.
- 2.1.3 One electrical connector, together with an assembly tool not required by this contract, has been modified and built to accept an interfacial insert. This connector will be sent to Bob Hendrix, Technical Monitor. The connector will mate with any MIL-C-26482 plug assembly having the 22-21S arrangement in the normal position.
- 2.2 Design Comments for Future Development
- Interfacial inserts manufactured for this contract were made 2.2.1 from standard hard epoxy molds. New molds should be made to provide a contour more suitable for insertion and removal of the interfacial insert. The molding gate should be reduced in size so it can be trimmed below the sealing surface.

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REPORT SERIAL NO. 1720
PAGE 2 OF 8

- 2.2.2 A more reliable insert-to-seal bond must be incorporated. The one used on these samples did not survive the temperature life testing.
- The interfacial insert L-25274-604 is visually aligned and positioned in the shell. An assembly tool is used to seat the interfacial insert in the shell. A visual check is required to assure that the interfacial insert is properly seated.
- Future Testing of interfacial inserts made from new molds, assembled in modified shells and mated with standard connectors of the type desired to be qualified will be required to assure the design's performance.
- 2.2.5 During testing, particular attention should be given to the circumferential seal after exposure to the environments for excess wear of contacts and maintenance of insert position during and after all testing.
- 2.2.6 For connectors not having asymmetrical insert patterns with respect to the main key or keyway, the standard socket insert can not be used in the interfacial insert connector.
- 2.2.7 See L-25274-604 & L-25274-602 for illustration and modification dimensions for interfacial insert, modified plug and receptacle connector assemblies.
- 2.3 Study Requirements
- Upon receipt of NASA's request to quote on the interfacial insert for electrical connectors, a review of the concept was undertaken. Various methods of inserting the interfacial insert and retaining it in a modified shell were considered. Methods investigated included separate inserts with an extra threaded retaining member or locking springs.

It was decided that the best way to meet the design requirements and provide an economical end unit, the locking mechanism and interfacial insert should be one unit. Bendix proposal No. 1003 "Interfacial Inserts for Electrical Connectors" was submitted and accepted by NASA for prototype assembly.

The approach chosen by Bendix offers the following design features:

- a. Retention device is molded as part of interfacial insert
- b. Interfacial insert is molded using silicone rubber different rubber materials can be used to accommodate special environmental situations such as unusual temperature extremes or unusual fluid immersion requirements.
- c. Shell length increased by .600 inch.
- d. Standard insert assembly components and assembly procedures can be used for retaining the socket contact insert assembly in the modified shell.

## The Bendix Corporation Electrical Components Division Sidney, New York

REPORT SERIAL NO. 1720

PAGE 3 OF 8

- e. The increase in weight of a connector assembly for a 22-21 arrangement will be .150 pounds.
- f. Only one interfacial seal will be required since the molded rubber insert will provide a circumferential seal at shell I.D.
- g. Connectors with interfacial inserts will mate with standard connectors. The interfacial inserts manufacured in this study are designed for use in modified MIL-C= 26482 series II connectors.
- 2.4 Concept Comments
- 2.4.1 The following comments are applicable to the interfacial insert with regard to anomalies and advantages listed in the Disclosure of Invention Attachment 2 of subject contract.
- 2.4.1.1 Defects such as damaged seals, recessed contacts and bent or broken pins present a serious problem for any connector assembled on final system hardware.
- 2.4.1.1.1 The interfacial insert can do much to eliminate the cause of damaged seals and bent or broken pins due to improper assembly, since contacts are molded in place and seals are assembled over pins. The problem of damaged seals and bent or broken pins after assembly is eliminated since interfacial inserts are easily removed and replaced with new interfacial inserts without removing connectors from harnesses or housings.
- 2.4.1.1.2 The interfacial insert will have no effect on the problem of recessed contacts since this is strictly a problem of improper assembly.
- The advantages as stated in the disclosure of invention will be discussed in the order in which they appear.
- Increased Reliability It is true that problems caused by the above anomalies will be reduced to a minimum with the incorporation of the interfacial insert. However, the amount of contacts required to make an electrical connector will increase by 50%, mating connections will increase by 100%, one additional assembly will be required and a sealing joint will also be added. It is felt that without the benefit of final design testing and in the absence of field use data the reliability will be similar to the connector being replaced.
- 2.4.2.2 Simplified Maintenance The prime objective is to simplify maintenance by minimizing the effect of the stated anomalies. This interfacial insert will provide an easy means of replacing damaged interfacial seals or contacts, without costly reworking of assembled and sealed systems.

REPORT SERIAL NO.

1720

PAGE 4 OF 8

- 2.4.2.3
- Interfacial Seal Damage due to Contact Installation or Removal Tools The interfacial insert provides a molded-in contact, eliminating the problems of contact insertion and removal.
- 2.4.2.4
- Elimination of Damage to Interfacial Seals due to Bonding to a Rigid Surface It is not felt that this is an advantage since most interfacial seals are bonded to rigid surfaces. It should be noted that, in the design proposed by Bendix, the interfacial seal is bonded to a resilient member. It is the elimination of assembly and disassembly in the interfacial seal area that will reduce seal damage.
- 2.4.2.5
- Reduction of Recessed Pins It is not felt that this problem is reduced since the design only replaces insertable pins with insertable sockets.
- 2.4.2.6
- Reduction of Pin Bending by Using a Harder Pin Material Due to the molding operation, contact materials will be of the same hardness for size 20 and size 22 contacts, and size 16 contacts will be somewhat softer using the molded in contacts as opposed to crimp contacts. Note that because the pin contacts are molded in a resilient insert the bending moment due to probe type damage will be reduced.
- 2.4.2.7
- Ease of Replacing Insert Defective insert assemblies are easily removed by pulling gently with a long-nosed pliers or similar tool on various contacts in turn, so as to ease the assembly out of its shell. A new insert assembly can readily be assembled by visually aligning insert with pattern and setting in place by use of a simple hand tool.
- 2.4.2.8
- Stocking of Only Socket Contacts and Tools The interfacial insert will eliminate the need to stock individual pin contacts. However, interfacial inserts will have to be stocked. Tools for contact insertion and removal are usually common for both pins and sockets so this is only a very minor problem. Also, the interfacial insert requires its own assembly tool.
- 2.4.2.9
- Only Socket Contacts on Harnesses to be Exposed The interfacial insert will eliminate the need to have exposed pins on harnesses during harness manufacturing.
- 2.4.2.10
- Crimp Tools Usually only one crimp tool is required for either pins or sockets.
- 2.4.2.11
- Selective Plating to Change Wear Patterns Rather than change platings to shift wear areas, it is suggested to use standard platings and when pin surfaces wear, replace the interfacial insert, utilizing interfacial insert as a connector saver.

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REPORT SERIAL NO. | 720

PAGE 5 OF o

- 2.4.2.12
- Interfacial Insert Connectors-Modified Standard Connectors While the changes to the standard shell are simple, the interfacial insert connector can not be made from standard shells. Insert assemblies symmetrical about the main key or keyways and socket contacts are standard components, and normal assembly methods can be used.
- 2.4.2.13

Hermetic Applications - Interfacial inserts with pins on one end and sockets on the other could be utilized on hermetic assemblies. It might be advantageous to use socket hermetic connectors and mate with standard interfacial insert assembly connectors.

- 2.4.3 The disadvantages as stated in the disclosure of invention will be discussed in the order in which they appear.
- 2.4.3.1 Increase in weight and length The increases in weight and length for a MIL-C-26482F series II wall mount having 21 size 16 contacts will be .15 pounds and .600 inches. The effect of this increased weight against the gain of easily repairing damaged connectors must be evaluated
- 2.4.3.2 Cost of adding an extra interfacial seal In the Bendix proposal only one interfacial seal is required. This is accomplished by using the resilient insert to provide a circumferential seal with the shell.
- 2.4.3.3 Tooling costs Costs to implement the interfacial insert must be compared with the saving in eliminated down-time caused by damaged pins.
- increase in contact resistance While there will be an increase in contact resistance of a mated connector, it should be noted that on the units tested the contact resistance upper control limit did not exceed the specification requirements.
- 2.5 Test Program
- 2.5.1 Samples
  - 15, L-25274-604 Interfacial Inserts
    - 4, 10-483523-21S Standard Socket Inserts
  - 84, 10-497007-16H Standard Socket Contacts
- 2.5.2 Test Schedule

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REPORT SERIAL NO.

PAGE 7 OF 8

1720

- 2.5.3 Test purpose The above samples and test schedule are to provide preliminary information on the suitability and possible design problems for incorporating the interfacial insert in a modified connector.
- 2.5.4 Test Description Paragraph references are in MIL-C-26482F unless otherwise noted.
- 2.5.4.1 Insulation Resistance Par. 3.6.7.1., Par. 4.6.8.1 except samples are not wired.
- 2.5.4.2 High Potential Par. 3.6.9.1, Par. 4.6.10.1.
- 2.5.4.3 Contact Resistance Record contact resistance after wiring two standard socket contacts (6 in. method) and mating sockets to both sides of the pin contact at .100 in from the interfacial insert body.
- 2.5.4.4 Contact Retention Test two contacts per interfacial insert for contact retention. Apply loads to both ends of pin contact. Apply 20 pounds maximum load.
- 2.5.4.5 Insertion Forces Interfacial Insert to Simulated Shells Record the axial force required to insert an interfacial insert into a simulated plug shell with a standard socket insert.
- 2.5.4.6 Interfacial Insert Removal Remove interfacial insert from shell by applying small axial loads to the pin contacts.
- 2.5.4.7 Contact Retention to Destruction Record the axial load at which the pin contact will be dislodged from the interfacial insert. Test four contacts per interfacial insert, two contacts from each side.
- 2.5.4.8 Temp Life Par. 3.6.37 and Par. 4.6.37.
- 2.5.4.9 Insertion Forces of Interfacial Insert and Socket Insert Record the axial force required to assemble interfacial insert into standard insert and contact assembly.
- 2.5.4.10 Thermal Shock Par. 3.6.13 and Par. 4.6.13.
- 2.5.5 Test Results
- 2.5.5.1 Insulation Resistance All units passed the 5000 megohm min requirement. See data sheet 1.
- 2.5.5.2 High Potential All samples passed the high potential at 2300 VAC. See data sheet 2.
- 2.5.5.3 Contact Resistance The combination of two mating joints and extra length did not cause millivolt drops in excess of the 45 MV drop min. See data sheet 3.

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REPORT SERIAL NO.

1720

GE 8 OF 8

2.5.5.4

Contact Retention - Due to the resiliency of the insert material contact retention was not run to 25 pounds. The location of the contacts at a given load and the load required to obtain a given displacement was recorded. See data sheets 4 & 5. The reason for the larger displacements when applying pushout loads from the rear of the insert assembly is the interfacial seal is a softer rubber than the insert and was yielding under the pushout load. Displacement of the contact is occurring at .0055/pounds.

- 2.5.5.5
- Contact Retention to Destruction The average force to release the contacts was 7.96 pounds. See data sheet 8.
- 2.5.5.6
- Temp Life There was no damage to inserts, seals or contacts; however, the bond at the insert-seal interface did not hold up. The force to release contacts increased to 13.66 pounds average.
- 2.5.5.7
- Temp Cycle There was no damage to inserts, seals, contacts or bond joints. The force required to release the contacts was 7.64 pounds average.
- 2.5.5.8

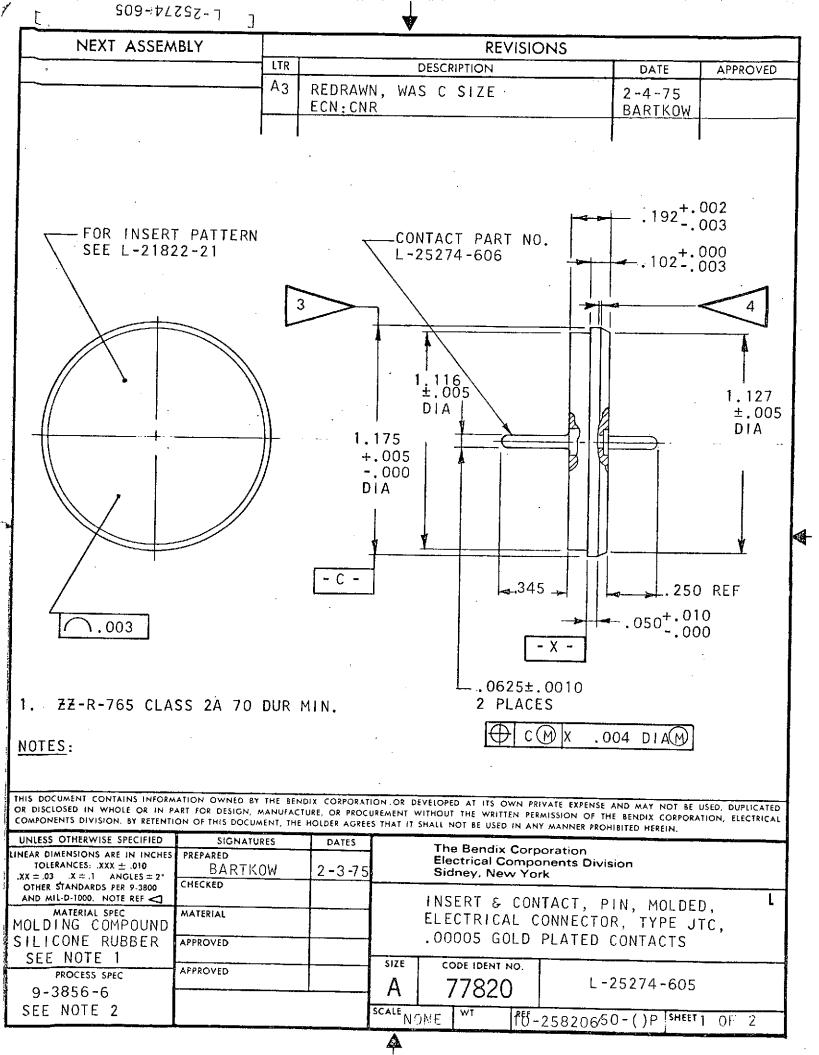
Simulated Shell Insertion Forces - The forces to insert the interfacial insert into three different shell openings were recorded using an insert with a full complement of mating socket contacts to push the interfacial insert into position. The forces required to remove the interfacial insert by pulling on the mated insert were also recorded. See data sheet 6. The force to insert the interfacial insert into a standard insert and contact assembly was also recorded. See data sheet 7.

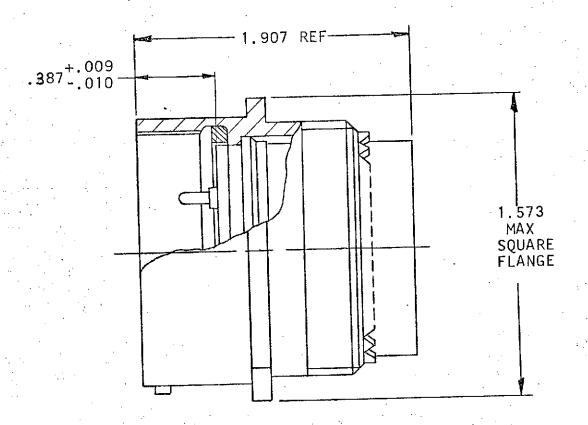
The results of this test indicate that a shell I.D. of I.155 in. and an insert with a full complement of contacts installed in the shell would retain the interfacial insert in its required position after unmating an insert with a full complement of contacts.

A connector assembly utilizing an assembled insert, interfacial insert and an I.D. of I.155 in. was mated and unmated 50 times with an insert with a full complement of contacts. The interfacial insert did not come out of the shell during the durability testing.

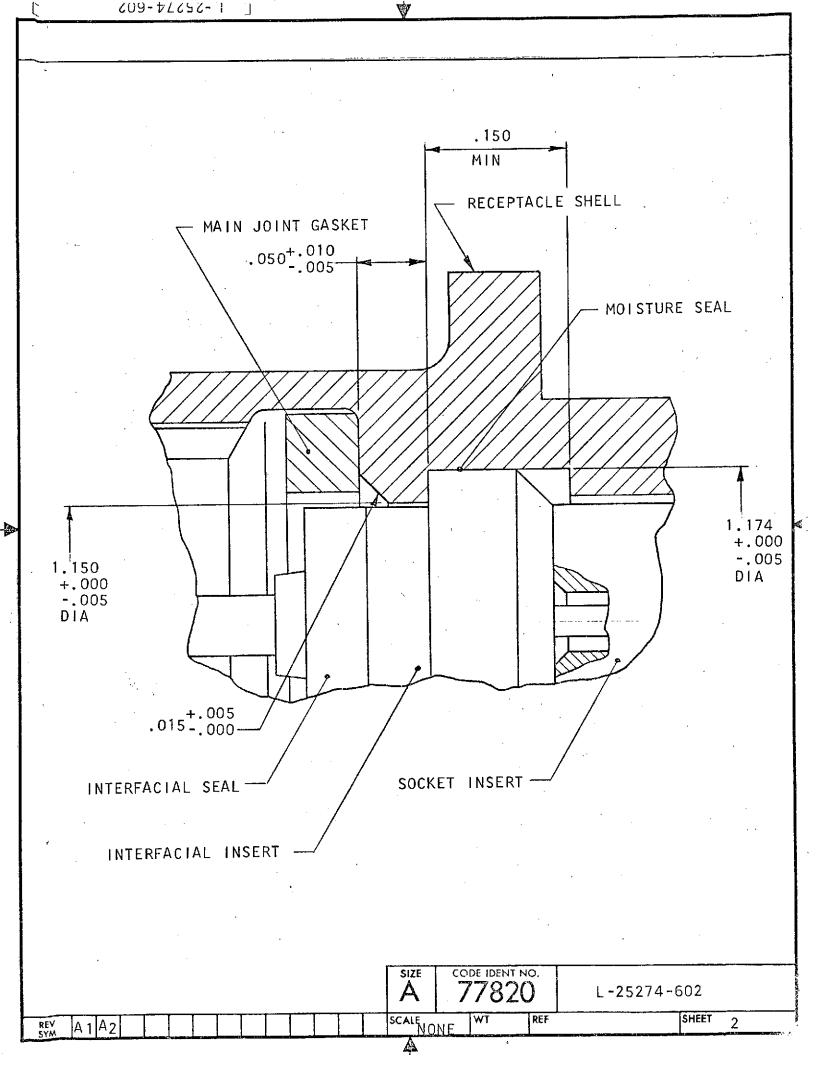
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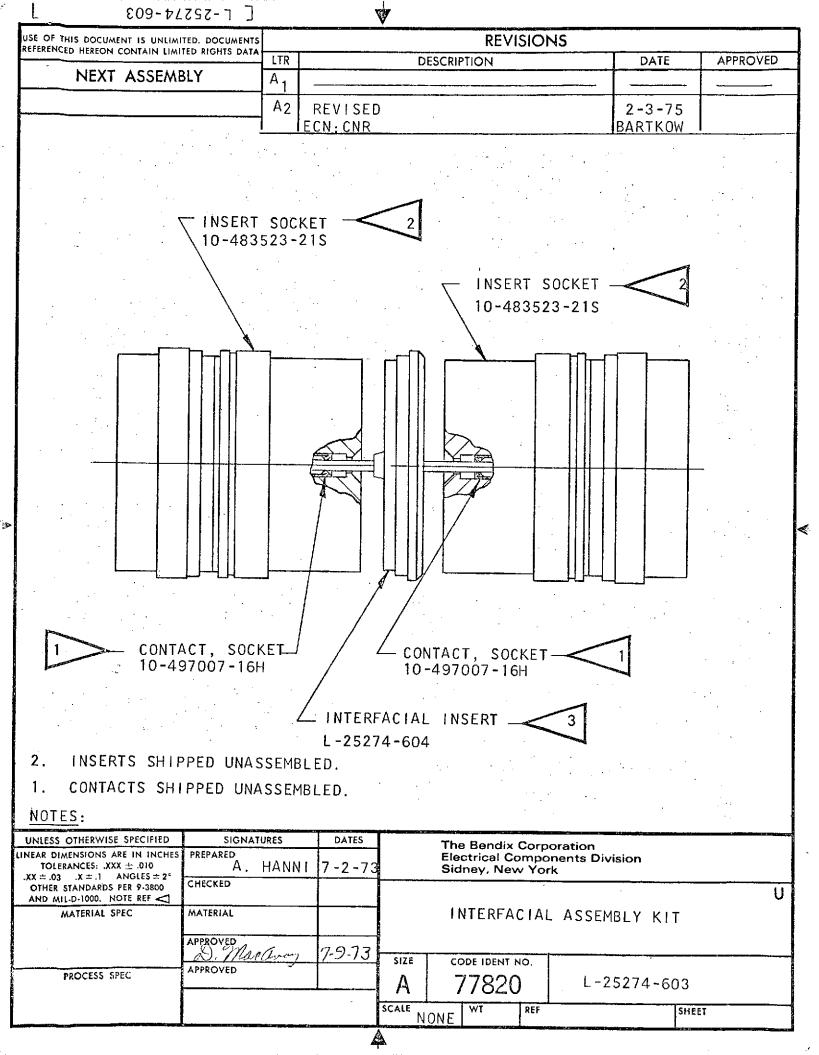
Interfacial Insert Removal - By applying small axial loads to the pin contacts of the interfacial insert, the interfacial insert was easily removed from an assembled connector.





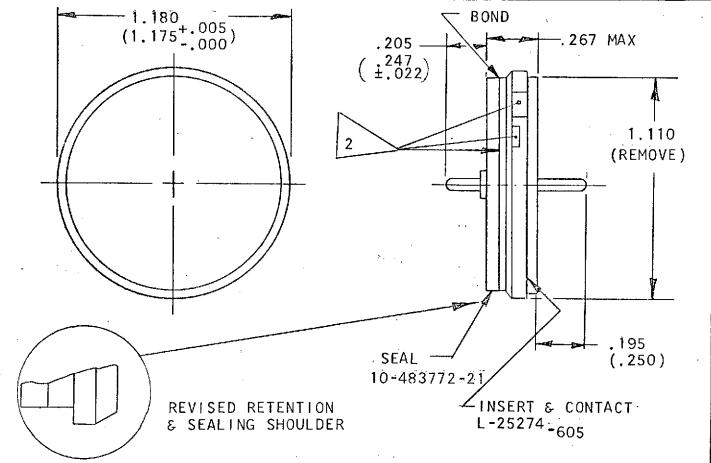
UNLESS OTHERWISE SPECIFIED	SIGNATURES	DATES	The Bendix Corporation Electrical Components Division					
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.XX ± .03 .X ± .1 ANGLES ± 2° OTHER STANDARDS PER 9-3800 AND MIL-D-1000. NOTE REF ✓	CHECKED		INTERFACIAL INSERT,	U				
MATERIAL SPEC	MATERIAL		ASSEMBLED IN MODIFIED MIL-C-26482 CONNECTOR, SHELL SIZE					
	D. Mac avoy	7-9-73	SIZE CODE IDENT NO.					
PROCESS SPEC	APPROVED	<u> </u>	A 77820 L-25274-602					
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NEXT ASSEMBLY	REVISIONS								
Y	LTR	DESCRIPTION	DATE	APPROVED					
	- A <sub>1</sub>								
	A <sub>2</sub>	CHANGED SEAL P/N ECN; CNR							
	A3	WAS L-25274-606 ECN; CNR	4-26-74	Marino					
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	A6	REVISED ECN: CNR	Zā3-75w						



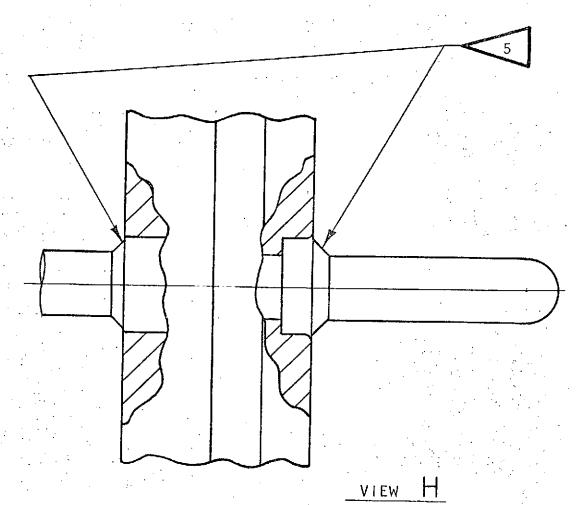
2. FULL SHOULDER GATE RELOCATED.

1.() DIMENSIONS ARE PROPOSED CHANGES TO ACTUAL MEASURED DIMENSIONS.

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LINEAR DIMENSIONS ARE IN INCHES TOLERANCES: ,XXX ± .010 .XX ± .03	A. HANNI	7 -2 -73	Electrical Components Division Sidney, New York				
OTHER STANDARDS PER 9-3800 AND MIL-D-1000. NOTE REF	CHECKED						
MATERIAL SPEC	MATERIAL		INTERFACIAL INSERT ASSEMBLY FOR USE ON MODIFIED MIL-C-26482 SERIE				
	D. Mue avon	7-9-73	SIZE CODE IDENT NO				
PROCESS SPEC	APPROVED		A 77820 L-25274-604				
			SCALE WT REF SHEET				

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5. EITHER OR BOTH FACES OF CONTACT MAY BE DISTORTED DUE TO CLAMPING IN THE MOLD.

ENLARGED

- 4. TRIM GATES .000-.005 BELOW C. GATE NOT TO EXCEED .020 IN WIDTH.
- 3. NO FLASH PERMISSIBLE ON INDICATED AREA OF CONTACTS.
- 2. USING WHITE INK PRINT PER 9-3856-6 (PROCEDURE | OR ||) | IDENTIFYING LETTERS AND NUMERALS IN ACCORDANCE WITH AND IN POSITION SHOWN ON L-21822-22. ON THE REAR FACE OF INSERT IT IS PERMISSIBLE TO OMIT INSERT ARRANGEMENT NUMBER AND TRADEMARK. CONTACT IDENTIFICATION ON REAR FACE MUST INCLUDE ALL LETTERS AND NUMERALS LOCATED ON VERTICAL CENTERLINE AND OUTER PERIPHERY IF IDENTIFIED ON L-21822-21. LETTER HEIGHT TO BE .047 APPROX UNLESS OTHERWISE SPECIFIED ON L-21822-21.
- 1. SPECIFIED GENERAL TOLERANCES:

CORNERS SHARP .000-.010 CONCENTRICITY .005 TIR (RFS)

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SIZE	co 7	DE IDENT N	) )	L-25274-605
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LABORATORY DATA SHEET REPORT NUMBER DATE OF TESTS 8-20-74 HMP RH. +74°F 41% SPEC. INSULATION RESISTANCE ECL TEST SPECIMEN (S) INTERFACIAL TASERTS WE SHELL LPL PARA. ii. 3235 41.1-0-26482F SPEC LIMITS 4.6.8.1 -- 25274-604 TEST EQUIPMENT CAL. DATE DUE DATE 7 5000 MEGOHMS
TEST CONDITIONS 12-2-74 5-28-14 F0054 BX AUTOMATIC COUNTESTER METHON 302 CONDITION B MIL-STD - 202E 75000 SAMPLE # (MEGOHMS) PAS5 PASS PASS PASS. PASS PASS PASS P1155 PASS 10 DASS 11 PASS PASS 12 13 PASS PASS 14 15 PASS APPROVED BY TESTED BY REF. Bendix **Electrical** Components Division WITHESSED BY Sidney, New York 13818

LABORATORY DATA SHEET DATE OF TESTS REPORT NUMBER DIELECTRIC WITHSTALDING VOLTAGE (SEA LEVEL) 8-20-74 TEMP RH. TEST SPECIMEN (S) ECL OTY IS INTERFACIAL TRISERTS 10 11161-6 Ŀ⊋( PARA. M./-C-26483 SPEC. LIMITS 4.6.10.1 6-25274-604 CAL. DATE DUE DATE 8-8-74 BX AUTOMATIC CONN. TESTER 9-6-74 F1680 TEST CONDITIONS METHOD 30/ MIL-STO-202E THE DIALECTRIC WITHSTANDING VOLTAGE WAS BETWEEN EACH CONTACT AND ALL OTHER CONTACTS IN COMPONI. THE TEST VOLTAGE WAS GRADUALLY APPLIED AT BATE VOLTS PER SECONO, UNTIL A MAXIMUM VOLTAGE 2300 VAC RMS WAS ATTAINED THE MAXIMUM TET YOUTHER WAS PININTRINED FOR ONE MINITE NO EVIDENCE OF FLASHOVER, REGARDOUN, OF LENKAGE CHERKAT IN EXCEST OF ONE MILLIAMPERE ORIGINAL PAGE IS OF POOR QUALITY ΩEF.

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Sidney, New York 13838

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LABORATORY DATA SHEET

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LABORATORY DATA SHEET DATE OF TESTS REPORT NUMBER 8-22-74 CONTACT RETENTION TEST SPECIMEN (S) GTY IS NASA TAITER FACIAL TASENTS TEMP. R.H. +75% 38% ÉCL PARA. 3735 4-25274-604 TEST EQUIPMENT CAL. DATE DUE DATE SPEC. LIMITS PG1050 INSTRONITTO WIEXTENSOMETER 3-28-74 10-4-74 TEST CONDITIONS INSTRON CALIBO MEIGHTS PG1450 4-26-74 5-17-76 LOAD APPLIED TO FRONT OF DOUBLE PIN CONTACT . (INTERFACIAL SEAL SIDE) DEFL. @ DEEL O SAMPLEA LOAD R SAMPLE # LOAD @ OIS" DEFL CONTACT# .CIS DEFL. 4LB5 6000 CONTACTA M'LBS, KOAST (POUNDS) (INCHOS) (POUNDS) (INCHES) 3.8 11 .016 9 W 3.3 .019 10 3.3 9 S 020 3.... .020 2 P 2.7 024 2.5 10.5 .025 2 R 2.8 10 T c25 2.6 024 3 D 2.8 021 ,020 11 T 3./ 2.6 3 E 023 11.11 2.7 .022 3.6 4 X 3.0 .017 022 12 W 45 2.9 12 V 3,0 023 022 2.4 2.4 027 13 J .025 2.2 13\_H .027 3,0 1021 6 C 2.6 2.6 14 R .023 025 60 2.7 2,5 ,026 .022 26 7 H 15 C. 2.2 025 7 1 3.0 150 1024 2.4 24 8\_N 025 Average 2.80 0227 8 M 2.7 .022 TESTED BY REF. APPROVED BY

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LABORATORY DATA SHEET DATE OF TESTS REPORT NUMBER 8-22-74 CONTACT BETENTION TEST SPECIMEN (S) TEMP. → > C C F SPEC, R H. 38% ÉĊί NASA INTERFACIAL EPL NSENTS PARA. 1-25274-604 TEST EQUIPMENT 3735 DUE DATE CAL. DATE SPEC. LIMITS PG1050 3-28-24 TAISTROATETTO W/EXTENSIMETER 10-4-74 TEST CONDITIONS LOAD APPLIED TO REAR TNITRON' CALIR WEIGHTS PO1450 4-26.74 5-17-76 OF COUBLE PIN CONTACT. DEFLED SAMPLEF DEFL. B. SMOJELFF 2040 Q 1.000 00, 015 OFFL YLBS LOAD NIRS LON (POUNOS) (INCHES) (POUNDS) (INCHES) 029 1.8 1 N 2.7 039 9 X 028 9 U 1.0 042 1.9 .029 2 U 047 1.3 10\_P ,031 2 V 045 10 R 1.7 0.7 .039 .037 11 C 3 K 1.4 033 // D .035 4 G ,032 1.7 1,2 .041 12. X 12 N 4 H .041 .031 1.7 5 N 13 E 1.8 .033 026 2.0 .034 13 D 1.8 5 M 2.2 027 14 5 1.3 ,037 032 1.6 14 T 6 4 1.7 .037 2.1 030 15 K 7 V 044 1.5 1.2 032 7 K 15 J 1.6 040 ,042 1.0 039 1.61 0354 1.1 Average 45 039 8 B TESTED BY REF. APPROVED BY Bendix 4 **Electrical** Components Division WITNESSED BY Sidney, New York 13838 5

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LABORATORY DATA SHEET DATE OF TESTS. REPORT NUMBER 9-11-74 EMP. R.H. TUSERTION & REMOVAL FORCES EÇL TEMP. INTE-PACIAL INSERTS PPL 1-25274-604 SPEC. PARA. 3735 SAMPLE # 1, 2, 3 CAL. DATE DUE DATE SPEC. LIMITS PG1050 3-25-24 10-41-74 INSTRON TTC. TEST CONDITIONS SAMPLE NOTES SHELL PEAK PEAK # TNSIDE REMOVAL INSECTION FORCE FORCE DIAMETER (LBS) (LBS) (INCHES) 8.9 4.3 (i)1.170 2 7,2 (1) 12,4 4.3 7.6 (1) 1.163 9.6 19.6 10.8 (1) 2 230 (1) 18.6 9.3 (2) 1.155 31.5 12.0 2 (2) 28.6 10.7 3 12.2 (i)24.0 (1)(3)11.7 24.1 (1) INTERFACIAL INSEPT PULLED OUT OF SHELL WITH NOTES: INSERT EMOUAL (2) REMAINED IN (3)REVERSED APPROVED BY TESTED BY REF. Bendix 4 Electrical Components Division WITNESSED BY Sidney, New York 13838 6

	HURT D								DATE O	F TESTS.	IRE#O	RT NUMBER
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3	AB VU	8.7	8.2	7.7	7.7		
4	TU BC.	3.4	7.8	6.7	6.6		
5	LK XU	7.9	7.7	8.7	9.4		
6	XS KL	3.6	8.4	7.1	24		
7	EF UV	3.4	7.4	7.7	7,6		·
8	PR ST	2.3	3:4	2.1	7.5		·
9	AB WX	14.2	/3.4	15.4	16.1	<u> </u>	
10	XT LK	10.2	12.8	12,9	13.8	7	
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